## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10550102	YOKOTAGAWA ET AL.
Examiner	Art Unit
Niebauer, Ronald T	. 1609

SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES				
Search Notes	Date	Examiner		
Inventor search in EAST, eDAN; STIC search on SEQ ID NO:1 (results in eDAN)	4/16/07	rtn		
PubMed, EAST search	4/16/07	rtn		

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		
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